



FCC REPORT

Report Reference No...... : **TRE1702000702** R/C.....:34168
FCC ID..... : **YPVITALCOMBLINK**
Applicant's name..... : **ITALCOM GROUP**
Address..... : 1728 Coral Way, Coral Gables, Miami, Florida, United States
Manufacturer..... : UTCOM TECHNOLOGY CO.,LIMITED
Address..... : 4C, Block A, Central Avenue Building, BaoYuan Road, Xixiang Town, Baoan District, Shenzhen,518012
Test item description : Smart phone
Trade Mark : NYX
Model/Type reference..... : BLINK
Listed Model(s) : -
Standard : **FCC Part 27: MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES**
Date of receipt of test sample.....: Feb. 08, 2017
Date of testing.....: Feb. 09, 2017- Feb. 15, 2017
Date of issue.....: Feb. 16, 2017
Result.....: **Pass**

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Approved by
 (position+printedname+signature)....: Manager Hans Hu

Hans Hu

Testing Laboratory Name : **Shenzhen Huatongwei International Inspection Co., Ltd.**
Address..... : 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China

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1. Test standards and Report version

1.1. Applicable Standards

The tests were performed according to following standards:

[FCC Part 27](#): MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

[TIA/EIA 603 D June 2010](#): Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.

[FCC Part 2](#): FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS

[971168 D01 Power Meas License Digital Systems v02r02](#): provides a methodology for fully characterizing the fundamental power of wideband (> 1 MHz) digitally modulated RF signals acceptable to the FCC for demonstrating compliance for licensed transmitters.

1.2. Report version

Version No.	Date of issue	Description
00	Feb. 16, 2017	Original

2. Test Description

Test Item	Section in CFR 47	Result
RF Output Power	Part 2.1046 Part 27.50	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049	Pass
Conducted Spurious Emissions	Part 2.1051 Part 27.53	Pass
Band Edge	Part 2.1051 Part 27.53	Pass
ERP and EIRP	Part 27.53	Pass
Radiated Spurious Emissions	Part 2.1053 Part 27.53	Pass
Frequency stability vs. temperature	Part 2.1055(a)(1)(b) Part 27.54	Pass
Frequency stability vs. voltage	Part 2.1055(d)(1)(2) Part 27.54	Pass
Peak-Average Ratio	Part 27.50	Pass

Note: The measurement uncertainty is not included in the test result.

3. SUMMARY

3.1. Client Information

Applicant:	ITALCOM GROUP
Address:	1728 Coral Way, Coral Gables, Miami, Florida, United States
Manufacturer:	UTCOM TECHNOLOGY CO.,LIMITED
Address:	4C, Block A, Central Avenue Building, BaoYuan Road, Xixiang Town, Baoan District, Shenzhen,518012

3.2. Product Description

Name of EUT	Smart phone
Trade Mark:	NYX
Model No.:	BLINK
Listed Model(s):	-
IMEI :	352873080000387
Power supply:	DC 3.7V From internal battery
Adapter information:	Input:100-240Va.c., 50/60Hz, 0.15A Output: 5Vd.c.,500mA
Hardware version:	3702_BLINK
Software version:	BLINK_AMXNYX_V001R
RF Technical Description	
<input checked="" type="checkbox"/> FDD Band 4	
Operation Frequency:	Uplink:1710.7 MHz – 1754.3 MHz Downlink: 2110.7 MHz – 2154.3 MHz
Channel bandwidth:	<input checked="" type="checkbox"/> 1.4MHz <input checked="" type="checkbox"/> 3MHz <input checked="" type="checkbox"/> 5MHz <input checked="" type="checkbox"/> 10MHz <input checked="" type="checkbox"/> 15MHz <input checked="" type="checkbox"/> 20MHz
Power Class:	<input type="checkbox"/> Class 1 <input type="checkbox"/> Class 2 <input checked="" type="checkbox"/> Class 3 <input type="checkbox"/> Class 4
Modulation type:	<input checked="" type="checkbox"/> QPSK <input checked="" type="checkbox"/> 16QAM <input type="checkbox"/> 64QAM
Antenna type:	IntegralAntennna
Antenna gain:	1.0 dBi

3.3. Operation state

➤ Test frequency list

FDD Band 4						
Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]	
Low Range	1.4	19957	1710.7	1957	2110.7	
	3	19965	1711.5	1965	2111.5	
	5	19975	1712.5	1975	2112.5	
	10	20000	1715	2000	2115	
	15	20025	1717.5	2025	2117.5	
	20	20050	1720	2050	2120	
Mid Range	1.4/3/5/10/15/20	20175	1732.5	2175	2132.5	
High Range	1.4	20393	1754.3	2393	2154.3	
	3	20385	1753.5	2385	2153.5	
	5	20375	1752.5	2375	2152.5	
	10	20350	1750	2350	2150	
	15	20325	1747.5	2325	2147.5	
	20	20300	1745	2300	2145	

3.4. EUT operation mode

For RF test items

The EUT has been tested under typical operating condition. The Applicant provides software to control the EUT for staying in continuous transmitting and receiving mode for testing.

Test Items	Band	Bandwidth (MHz)						Modulation		RB #			Test Channel			
		1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full	L	M	H	
Max Output Power	4	v	v	v	v	v	v	v	v	v	v	v	v	v	v	v
26dB and 99% Bandwidth	4	v	v	v	v	v	v	v	v			v	v	v	v	v
Conducted Band Edge	4	v	v	v	v	v	v	v	v	v		v	v		v	v
Conducted Spurious Emission	4	v	v	v	v	v	v	v	v	v			v	v	v	v
E.R.P./ E.I.R.P.	4	v	v	v	v	v	v	v	v	v			v	v	v	v
Radiated Spurious Emission	4	v	v	v	v	v	v	v		v			v	v	v	v
Frequency Stability	4						v	v	v			v		v		
Peak-to-Average Ratio	4						v	v	v	v		v	v	v	v	v
Remark	<ol style="list-style-type: none"> The mark "v" means that this configuration is chosen for testing The mark "-" means that this bandwidth is not supported. The device is investigated from 30MHz to 10 times of fundamental signal for radiated spurious emission test under different RB size/offset and modulations in exploratory test. Subsequently, only the worst case emissions are reported. 															

3.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

● - supplied by the manufacturer

○ - supplied by the lab

		Length (m) :	/
		Shield :	/
		Detachable :	/
		Manufacturer :	/
		Model No. :	/

3.6. Modifications

No modifications were implemented to meet testing criteria.

4. TEST ENVIRONMENT

4.1. Address of the test laboratory

Laboratory: Shenzhen Huatongwei International Inspection Co., Ltd.

Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China

Phone: 86-755-26748019 Fax: 86-755-26748089

4.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories, Date of Registration: February 28, 2015. Valid time is until February 27, 2018.

A2LA-Lab Cert. No. 3902.01

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing. Valid time is until February 27, 2018.

FCC-Registration No.: 317478

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 317478, Renewal date Jul. 18, 2014, valid time is until Jul. 18, 2017.

IC-Registration No.: 5377B

Two 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No.: 5377B on Dec.03, 2014, valid time is until Dec.03, 2017.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory can also perform testing for the Australian C-Tick mark as a result of our A2LA accreditation.

4.3. Equipments Used during the Test

Output Power(Conducted) &Occupied Bandwidth&Emission Bandwidth&Band Edge Compliance&Conducted Spurious Emission					
No.	Equipment	Manufacturer	Model No.	SerialNo.	Last Cal.
1	UNIVERSAL RADIO COMMUNICATION	Rohde&Schwarz	CMU200	112012	2016/11/13
2	WIDEB.RADIO COMM.TESRER	Rohde&Schwarz	CMW500	1201.0002K50	2016/11/13
3	Spectrum Analyzer	Rohde&Schwarz	FSU26	201141	2016/11/13
4	Splitter	Mini-Circuit	ZAPD-4	400059	2016/11/13

Frequency Stability					
No.	Equipment	Manufacturer	Model No.	SerialNo.	Last Cal.
1	UNIVERSAL RADIO COMMUNICATION	Rohde&Schwarz	CMU200	112012	2016/11/13
2	WIDEB.RADIO COMM.TESRER	Rohde&Schwarz	CMW500	1201.0002K50	2016/11/13
3	Spectrum Analyzer	Rohde&Schwarz	FSU26	201141	2016/11/13
4	Climate Chamber	ESPEC	EL-10KA	05107008	2016/11/13
5	Splitter	Mini-Circuit	ZAPD-4	400059	2016/11/13

Output Power (Radiated) &Radiated Spurious Emission					
No.	Equipment	Manufacturer	Model No.	SerialNo.	Last Cal.
1	UNIVERSAL RADIO COMMUNICATION	Rohde&Schwarz	CMU200	112012	2016/11/13
2	Spectrum Analyzer	Rohde&Schwarz	FSU26	201141	2016/11/13
3	HORNANTENNA	ShwarzBeck	9120D	1012	2016/11/13
4	HORNANTENNA	ShwarzBeck	9120D	1011	2016/11/13
5	Ultra-Broadband Antenna	ShwarzBeck	VULB9163	538	2016/11/13
6	Ultra-Broadband Antenna	ShwarzBeck	VULB9163	539	2016/11/13
7	TURNTABLE	MATURO	TT2.0	----	2016/11/13
8	ANTENNA MAST	MATURO	TAM-4.0-P	----	N/A
9	EMI Test Software	Audix	E3	N/A	N/A
10	EMI Test Receiver	Rohde&Schwarz	ESIB 26	100009	2016/11/13
11	RF Test Panel	Rohde&Schwarz	TS / RSP	335015/ 0017	2016/11/13
12	High pass filter	Compliance Direction systems	BSU-6	34202	2016/11/13
13	Splitter	Mini-Circuit	ZAPD-4	400059	2016/11/13
14	Horn Antenna	SCHWARZBECK	BBHA9170	25841	2016/11/13
15	Horn Antenna	SCHWARZBECK	BBHA9170	25842	2016/11/13
16	Preamplifier	ShwarzBeck	BBV 9718	BBV 9718	2016/11/13
17	Broadband Preamplifier	ShwarzBeck	BBV743	9743-0079	2016/11/13
18	Signal Generator	Rohde&Schwarz	SMF100A	101932	2016/11/13
19	Amplifier	Compliance Direction systems	PAP1-4060	120	2016/11/13
20	TURNTABLE	ETS	2088	2149	2016/11/13
21	ANTENNA MAST	ETS	2075	2346	2016/11/13
22	HORNANTENNA	Rohde&Schwarz	HF906	100068	2016/11/13
23	HORNANTENNA	Rohde&Schwarz	HF906	100039	2016/11/13
24	WIDEB.RADIO COMM.TESRER	R&S	CMW500	1201.0002K50	2016/11/13

The calibration interval was one year.

4.4. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Normal Temperature/Tnor:	15~35°C
Relative Humidity	30~60 %
Air Pressure	950-1050 hPa

4.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01 "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 2" and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen Huatongwei laboratory is reported:

Test Items	Measurement Uncertainty	Notes
Frequency stability	25 Hz	(1)
Transmitter power conducted	0.57 dB	(1)
Transmitter power Radiated	2.20 dB	(1)
Conducted spurious emission 9KHz-12.75 GHz	1.60 dB	(1)
Conducted Emission 9KHz-30MHz	3.39 dB	(1)
Radiated Emission 30~1000MHz	4.24 dB	(1)
Radiated Emission 1~18GHz	5.16 dB	(1)
Radiated Emission 18-40GHz	5.54 dB	(1)
Occupied Bandwidth	-----	(1)
Emission Mask	-----	(1)
Modulation Characteristic	-----	(1)
Transmitter Frequency Behavior	-----	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=1.96$.

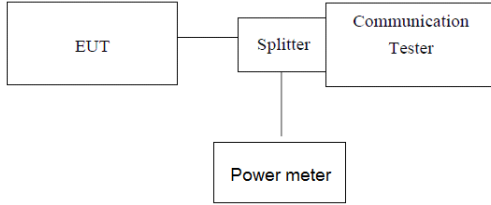
5. TEST CONDITIONS AND RESULTS

5.1. Conducted Output Power

LIMIT

N/A

TEST CONFIGURATION



Note: Measurement setup for testing on Antenna connector

TEST PROCEDURE

1. The transmitter output port was connected to base station.
2. The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.
3. Set EUT at maximum power through base station.
4. Select lowest, middle, and highest channels for each band and different modulation.
5. Measure the maximum burst average power.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Passed **Not Applicable**

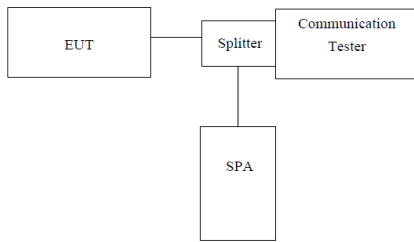
EUT Mode	Frequency (MHz)	Max Avg.Power QPSK (dBm)	Max Avg.Power 16QAM (dBm)
LTE Band 4	1710.70 – 1754.30	21.29	20.45

5.2. 99% & -26 dB Occupied Bandwidth

LIMIT

N/A

TEST CONFIGURATION



Note: Measurement setup for testing on Antenna connector

TEST PROCEDURE

1. The EUT's output RF connector was connected with a short cable to the spectrum analyzer
2. RBW was set to about 1% of emission BW, VBW= 3 times RBW.
3. -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

TEST MODE:

Please refer to the clause 3.3

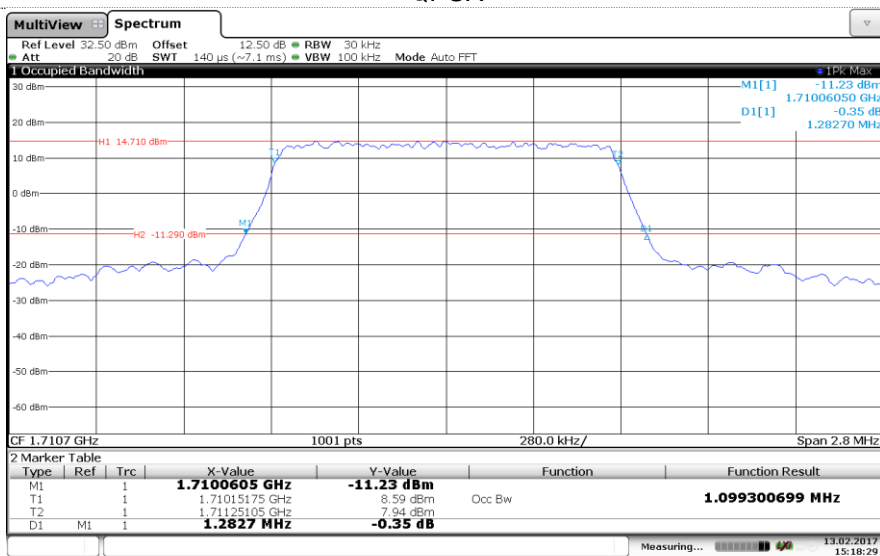
TEST RESULTS

Passed Not Applicable

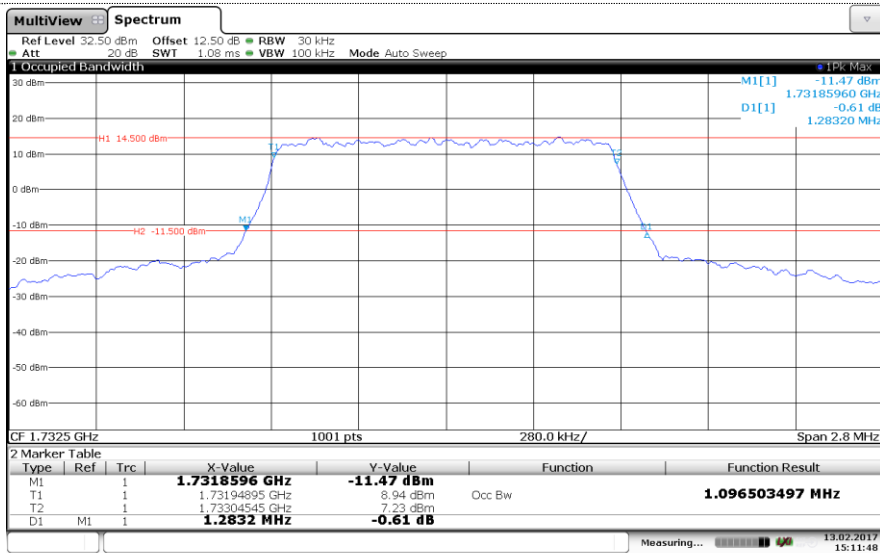
LTE Band 4					
Bandwidth	Channel	99% Occupy bandwidth (MHz)		-26dB bandwidth (MHz)	
		QPSK	16QAM	QPSK	16QAM
1.4MHz	Low	1.10	1.09	1.28	1.26
	Mid	1.10	1.10	1.28	1.29
	High	1.10	1.10	1.28	1.27
3MHz	Low	2.69	2.68	2.90	2.92
	Mid	2.69	2.68	2.92	2.95
	High	2.69	2.68	2.91	2.91
5MHz	Low	4.52	4.54	5.09	5.10
	Mid	4.53	4.51	5.09	5.07
	High	4.51	4.53	5.07	5.12
10MHz	Low	8.93	8.93	9.64	9.71
	Mid	8.95	8.95	9.84	9.68
	High	8.93	8.93	9.69	9.71
15MHz	Low	13.46	13.46	14.83	14.87
	Mid	13.55	13.55	14.97	14.95
	High	13.46	13.49	14.95	14.89
20MHz	Low	17.90	17.94	19.34	19.50
	Mid	18.02	18.02	19.47	19.52
	High	17.90	17.90	19.66	19.38

LTE Band 4-1.4MHz

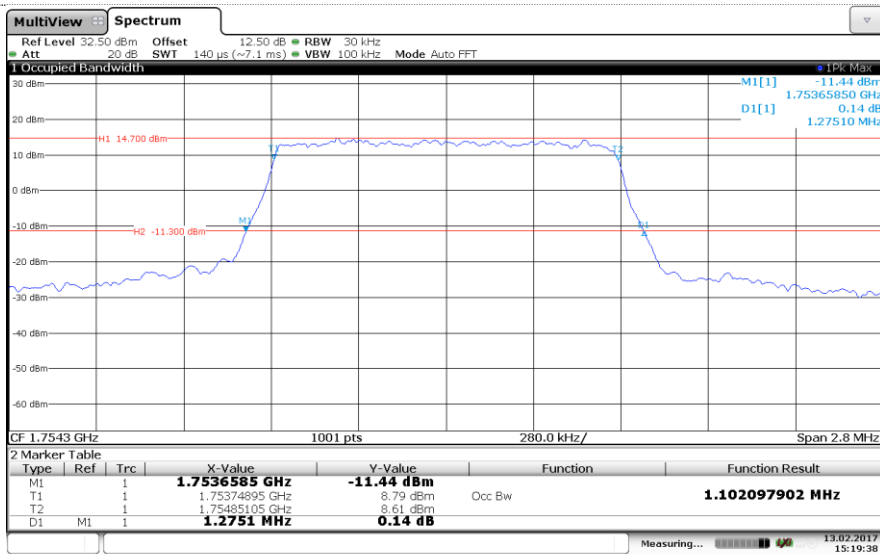
QPSK



Channel Low

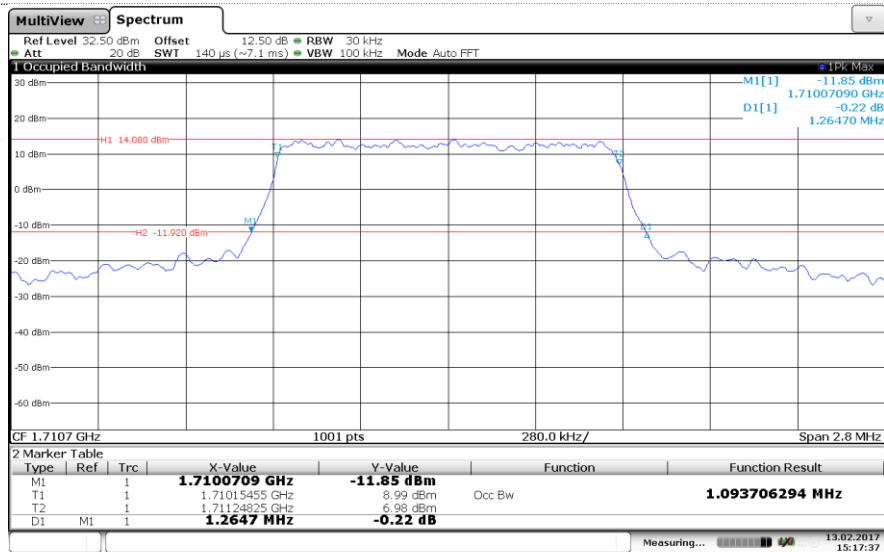


Channel Mid

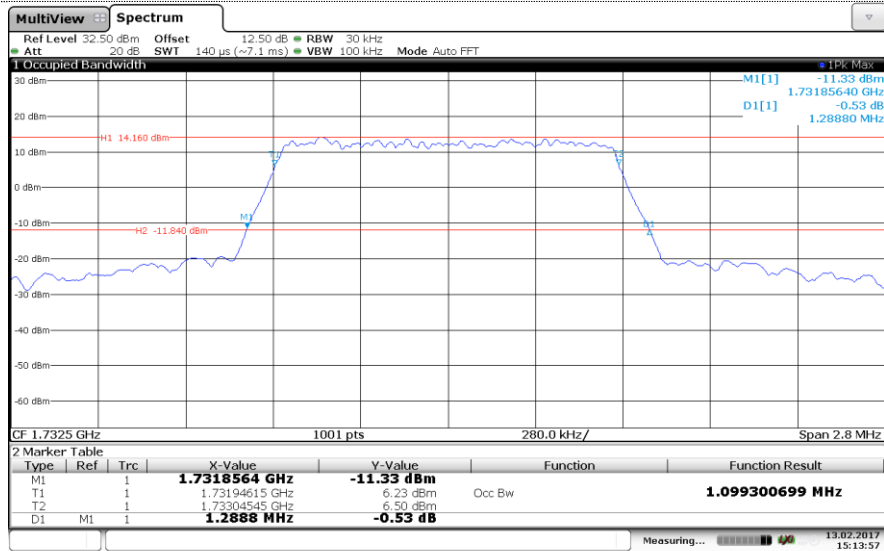


Channel High

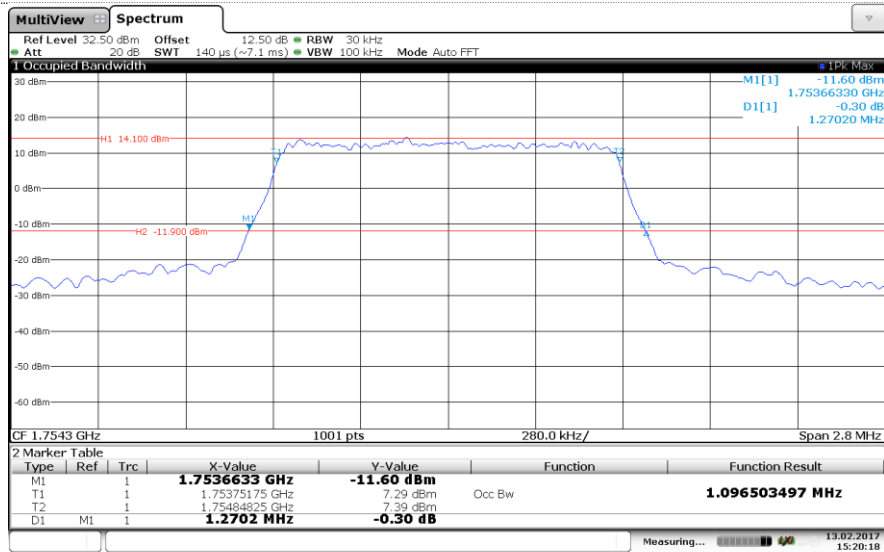
LTE Band 4-1.4MHz 16QAM



Channel Low



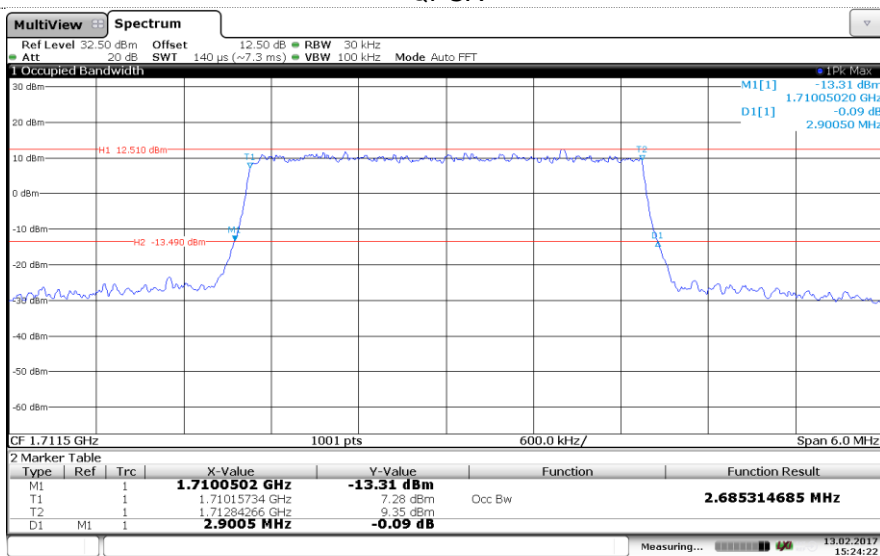
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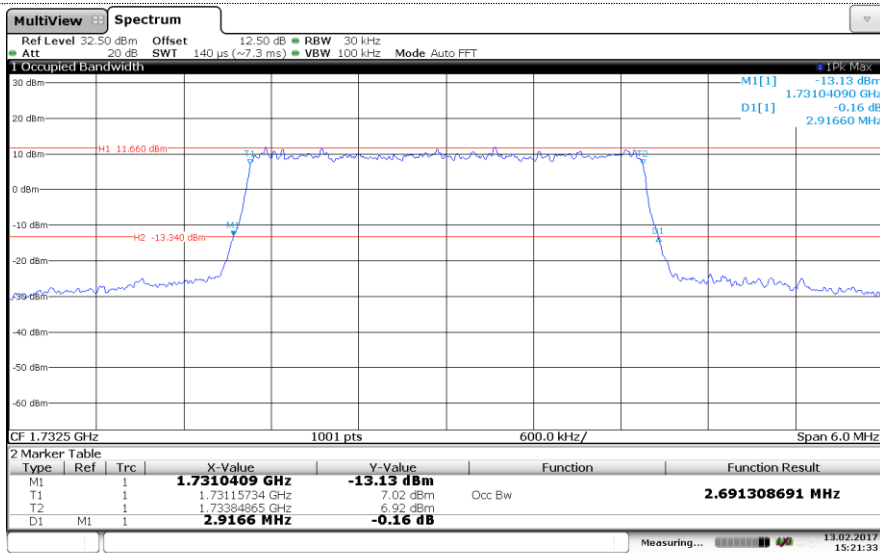
Channel High

LTE Band 4-3MHz

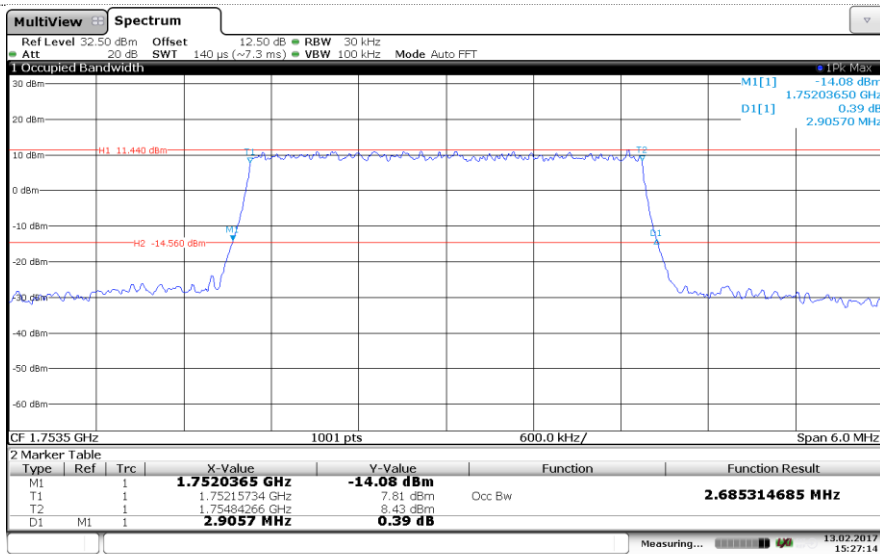
QPSK



Channel Low

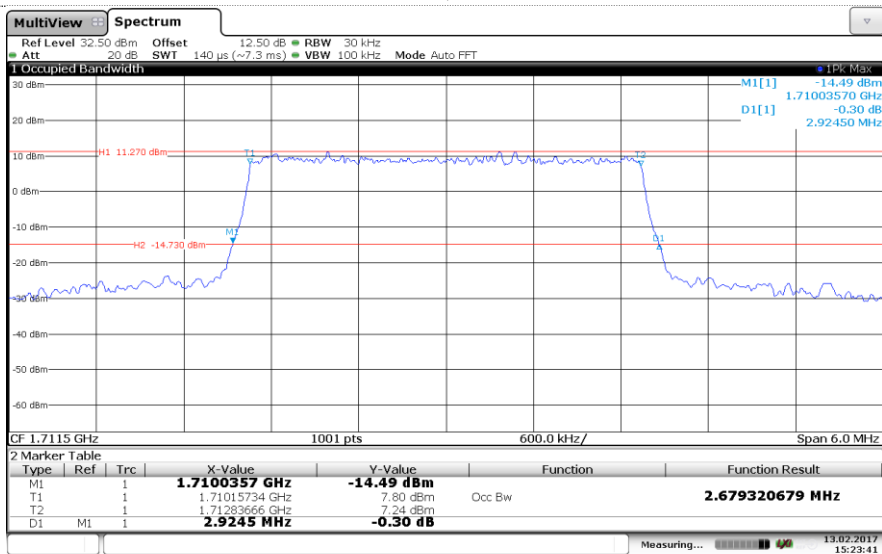


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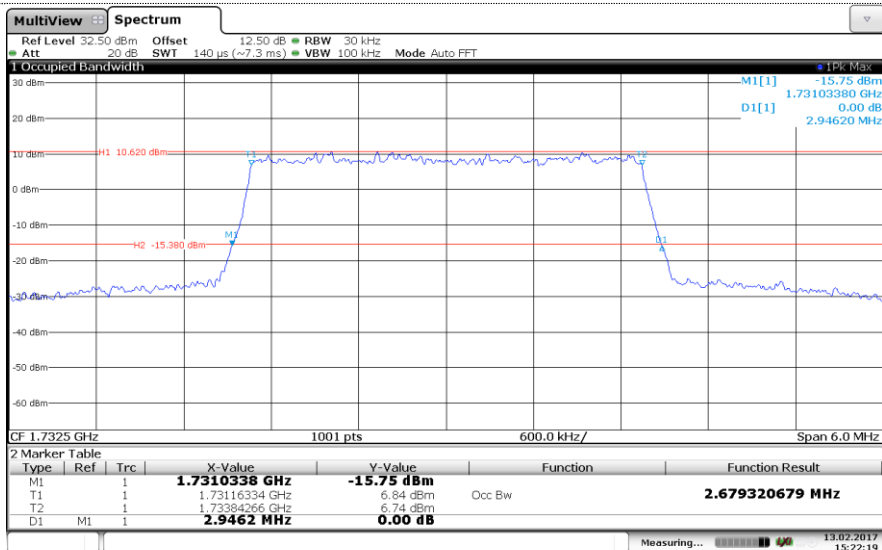


Channel High

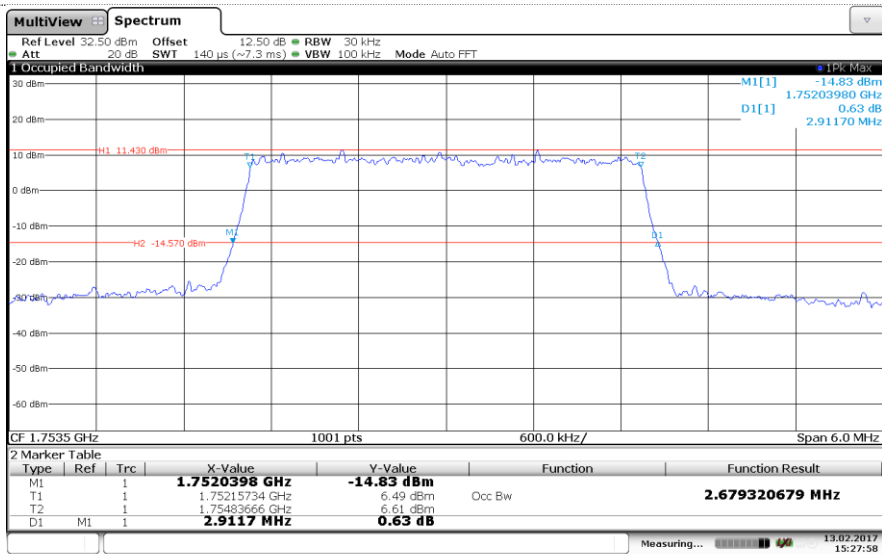
LTE Band 4-3MHz 16QAM



Channel Low

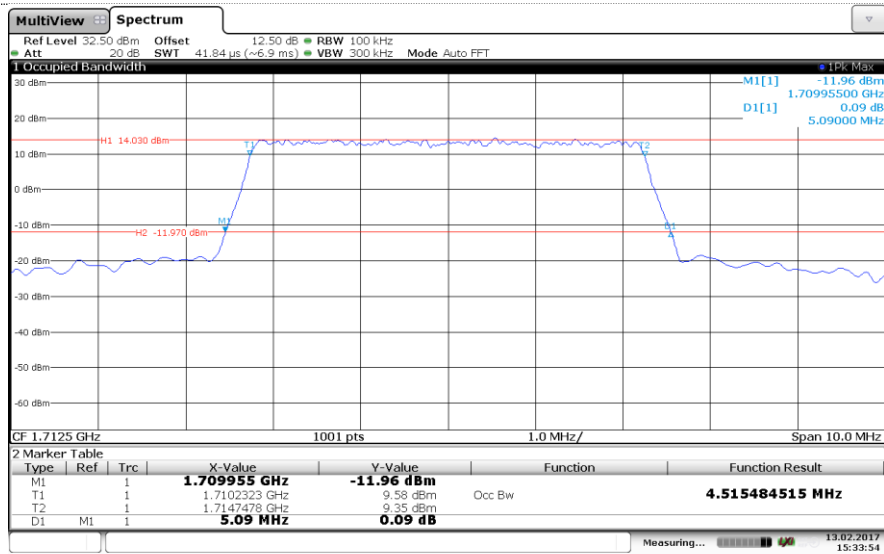


Channel Mid

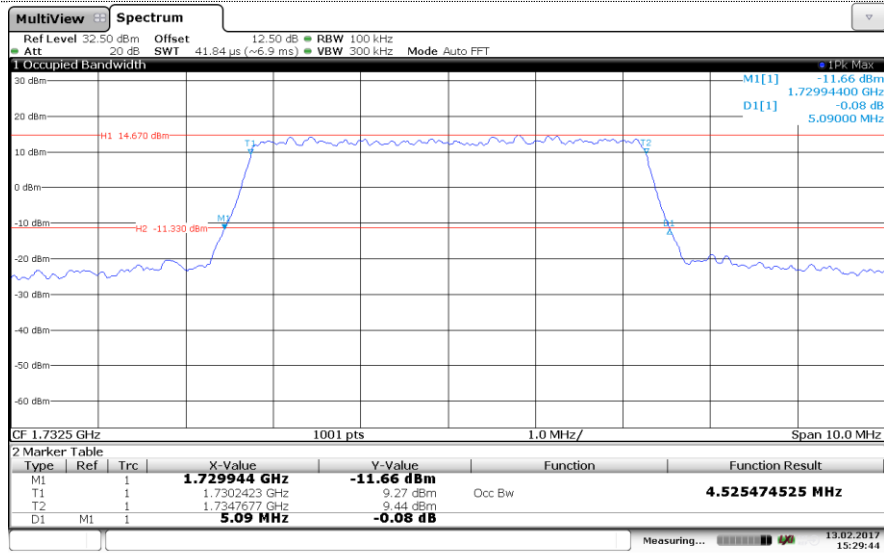


Channel High

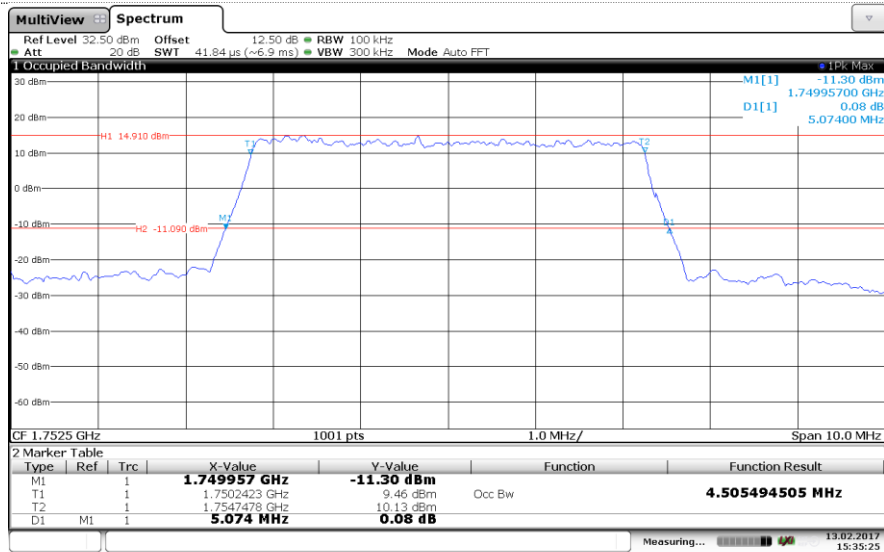
LTE Band 4-5MHz
QPSK



Channel Low

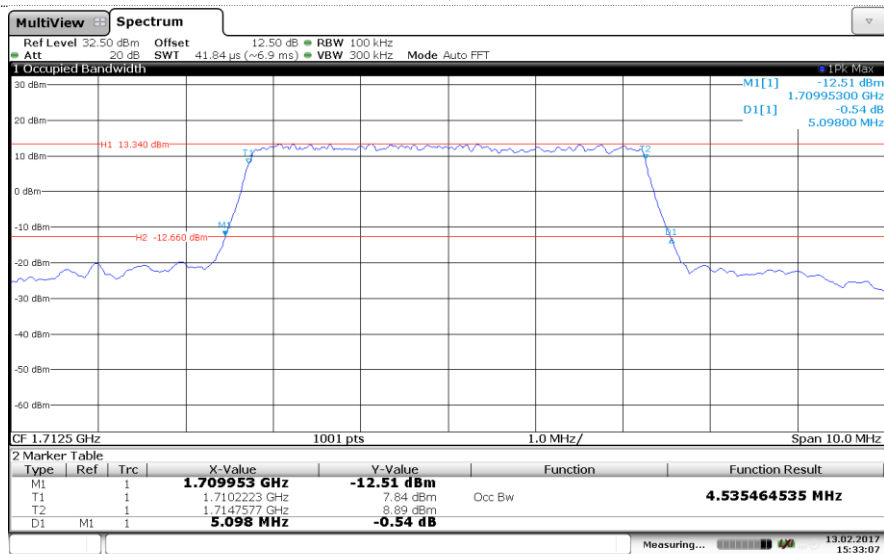


Channel Mid

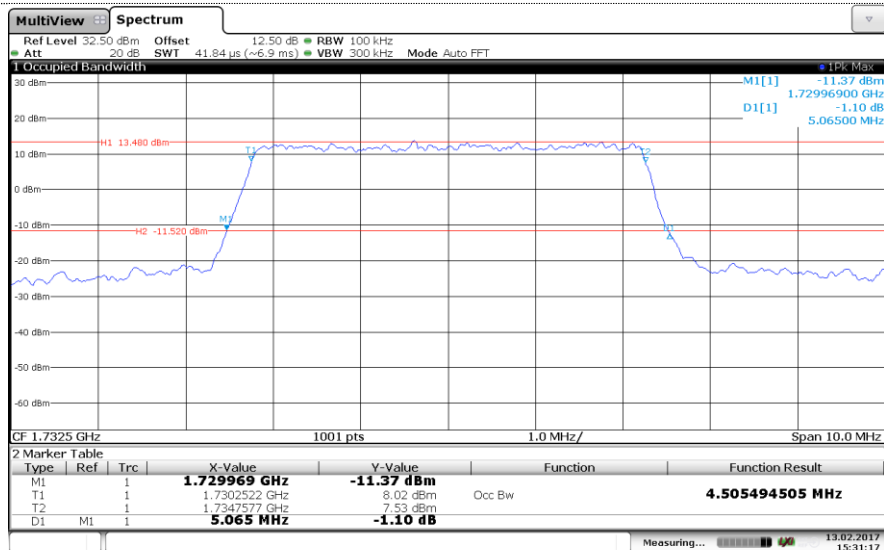


Channel High

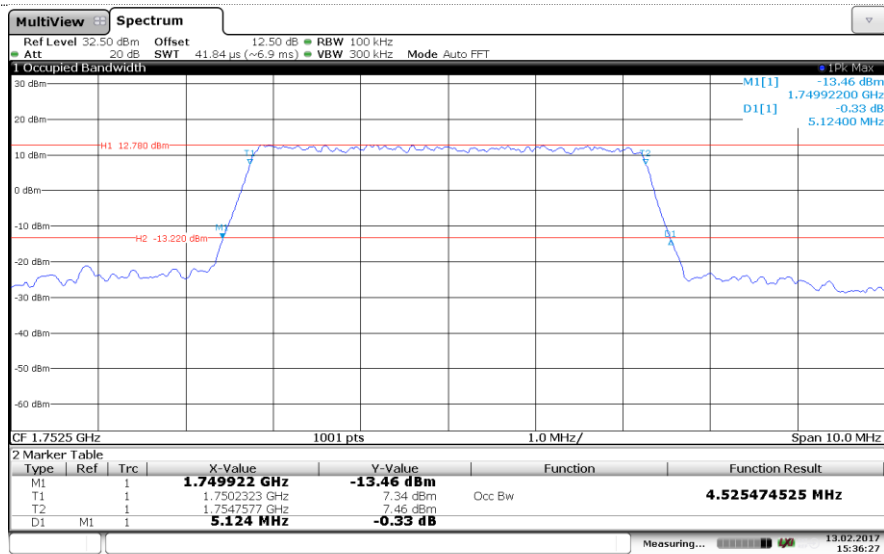
LTE Band 4-5MHz 16QAM



Channel Low



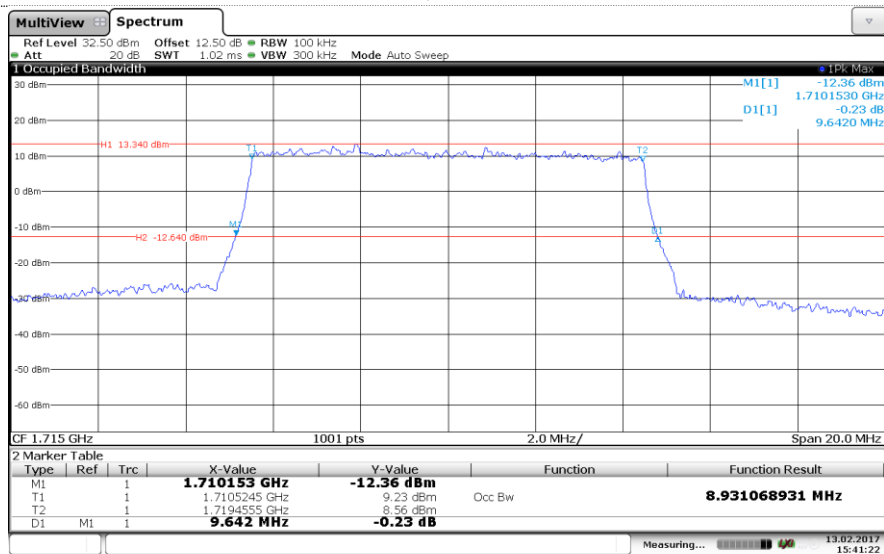
Channel Mid



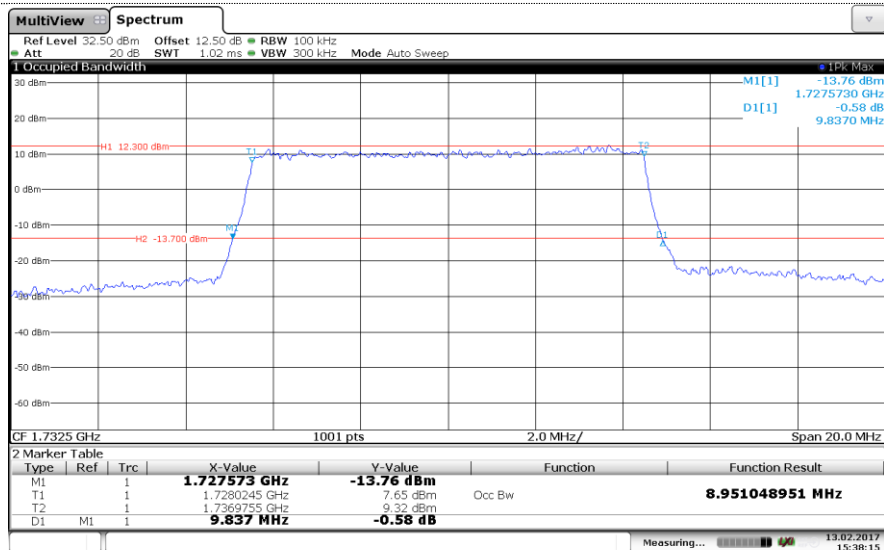
Channel High

LTE Band 4-10MHz

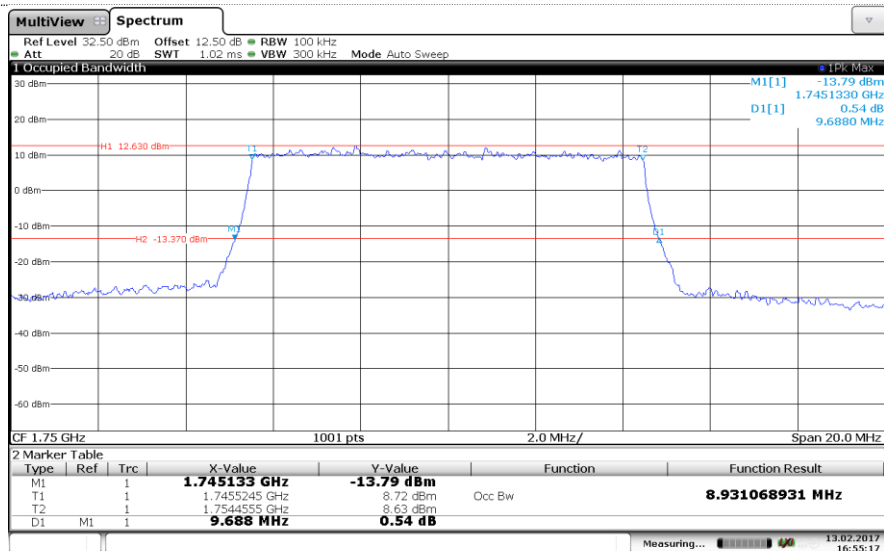
QPSK



Channel Low

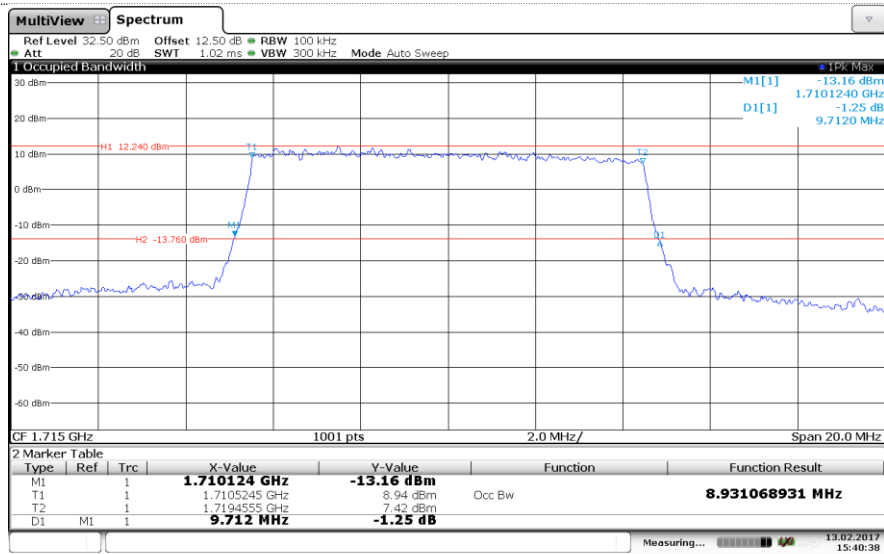


Channel Mid

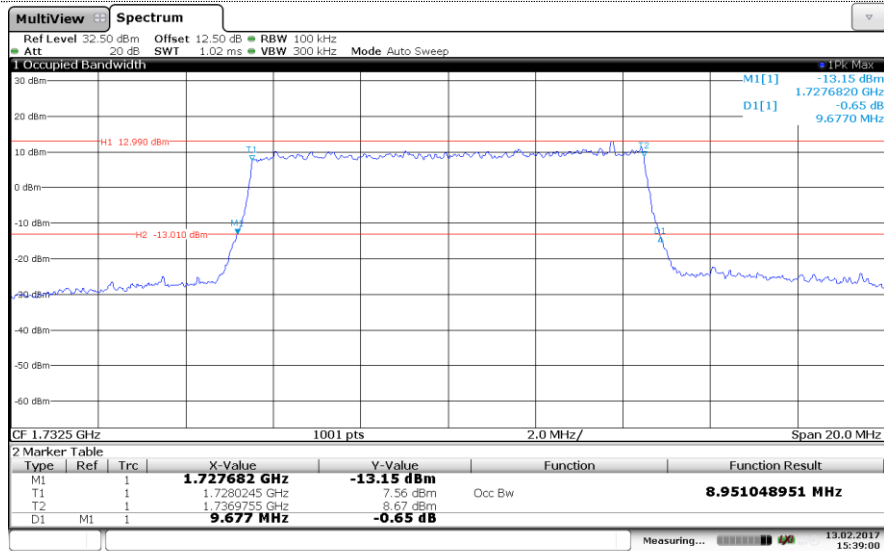


Channel High

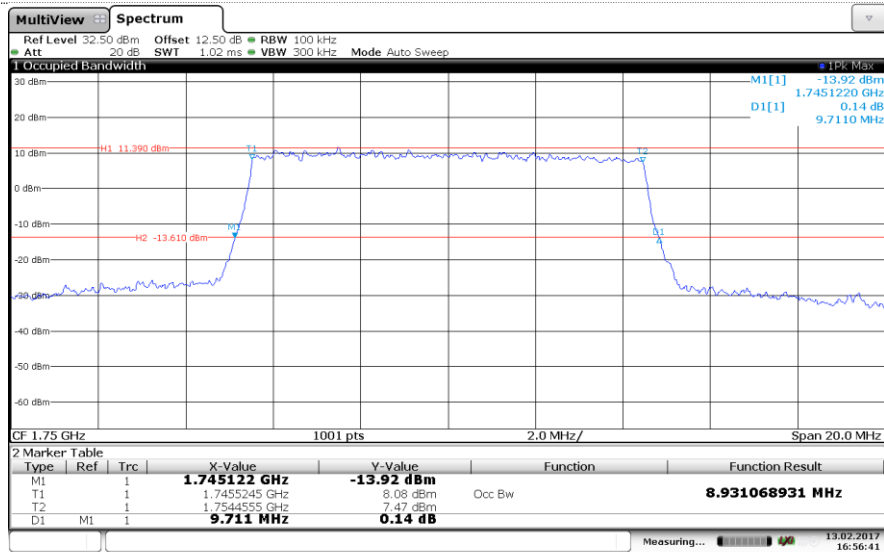
LTE Band 4-10MHz
16QAM



Channel Low



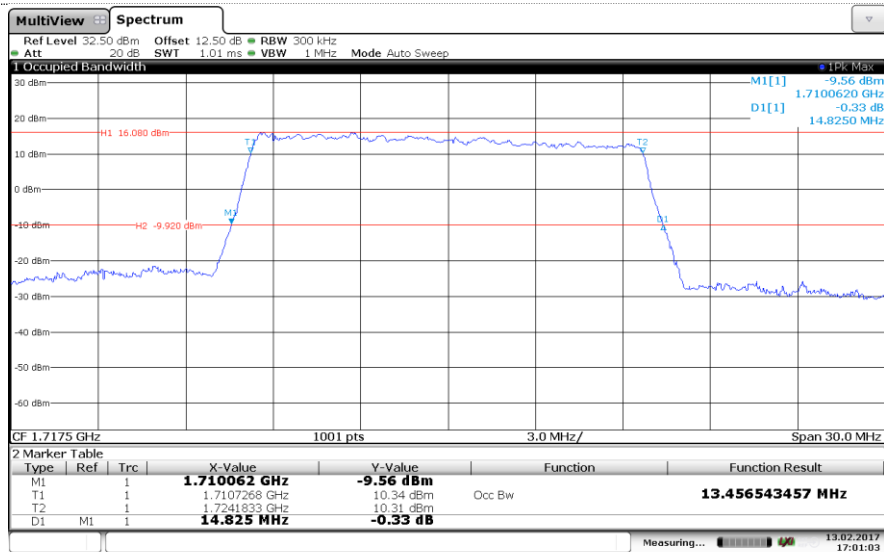
Channel Mid



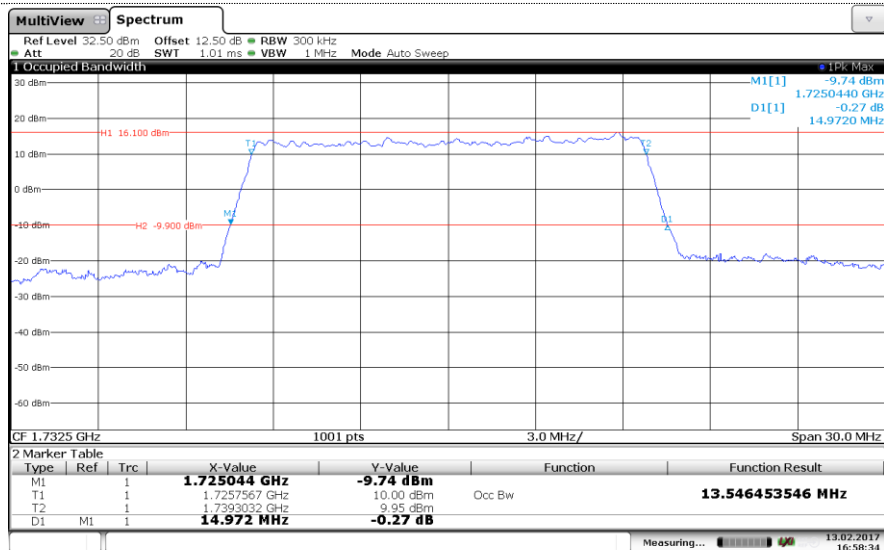
Channel High

LTE Band 4-15MHz

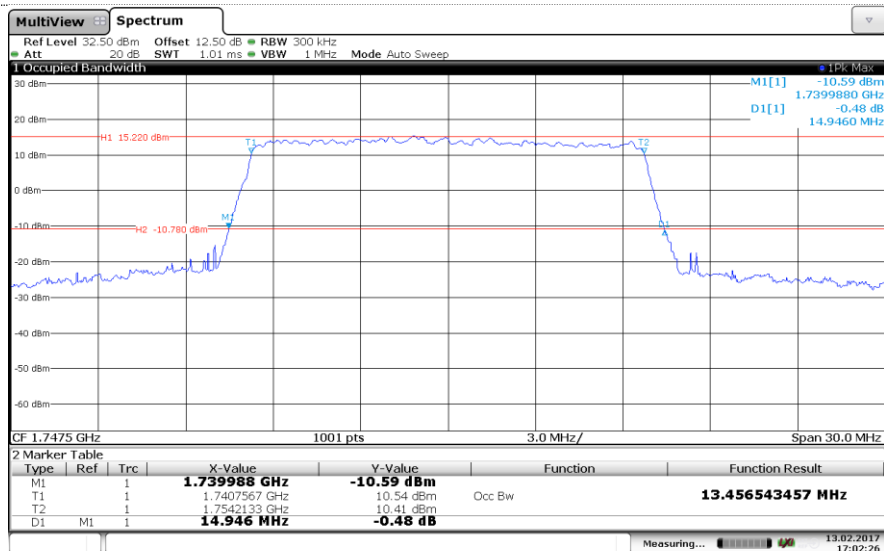
QPSK



Channel Low

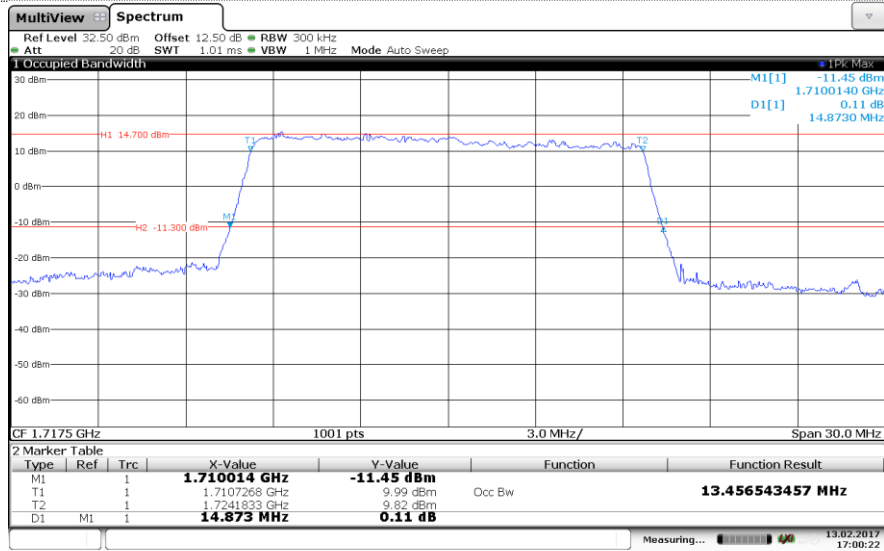


Channel Mid

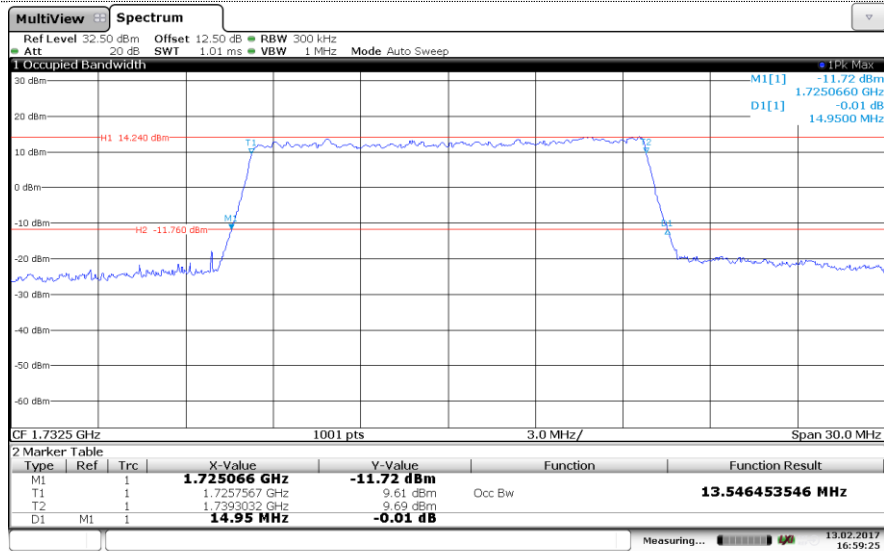


Channel High

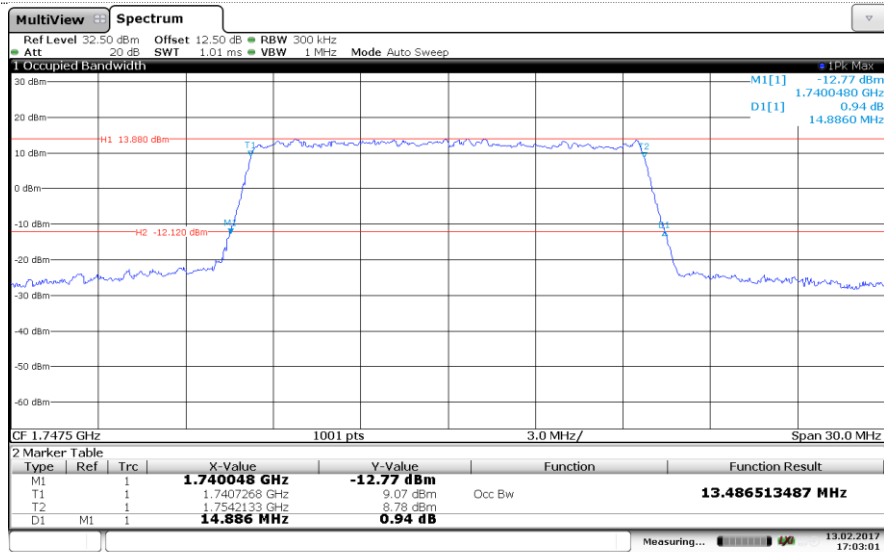
LTE Band 4-15MHz
16QAM



Channel Low



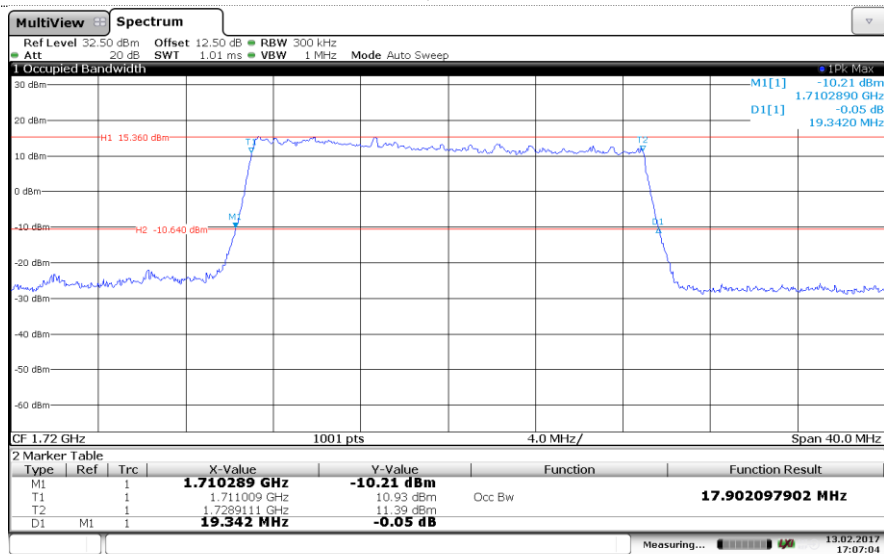
Channel Mid



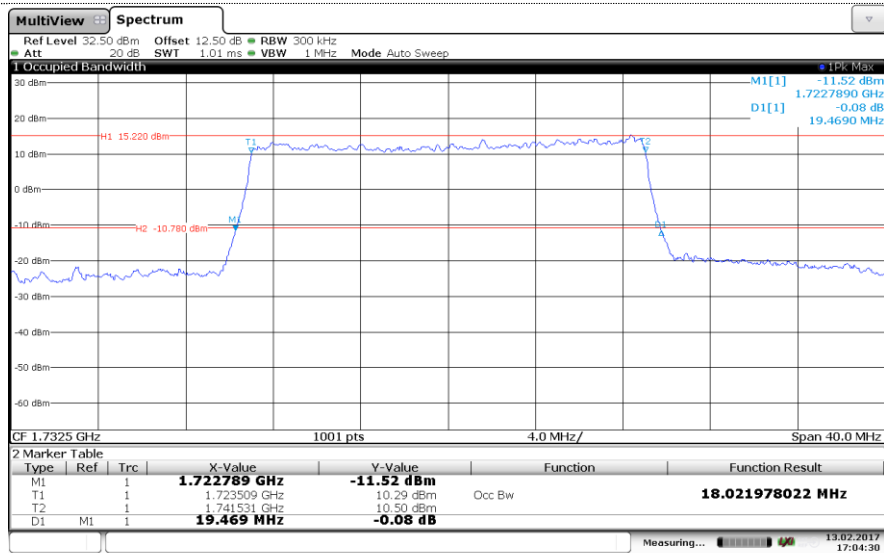
Channel High

LTE Band 4-20MHz

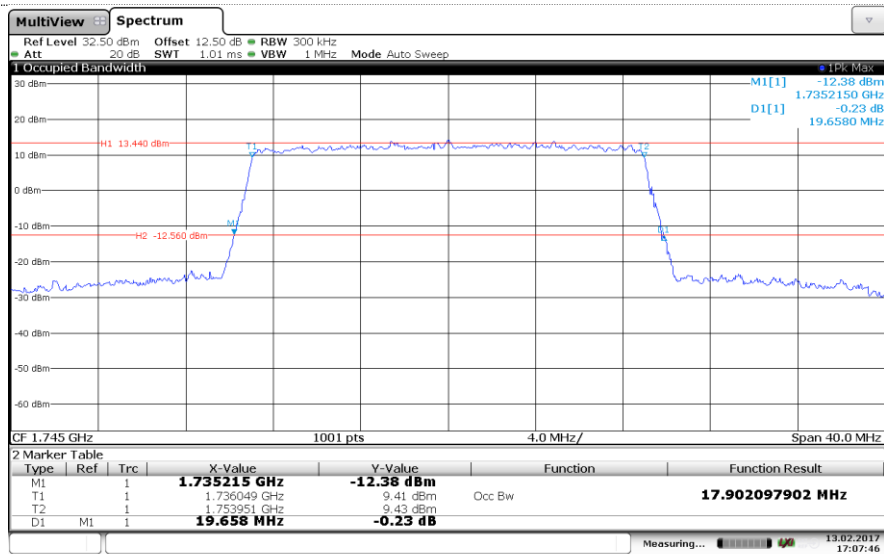
QPSK



Channel Low



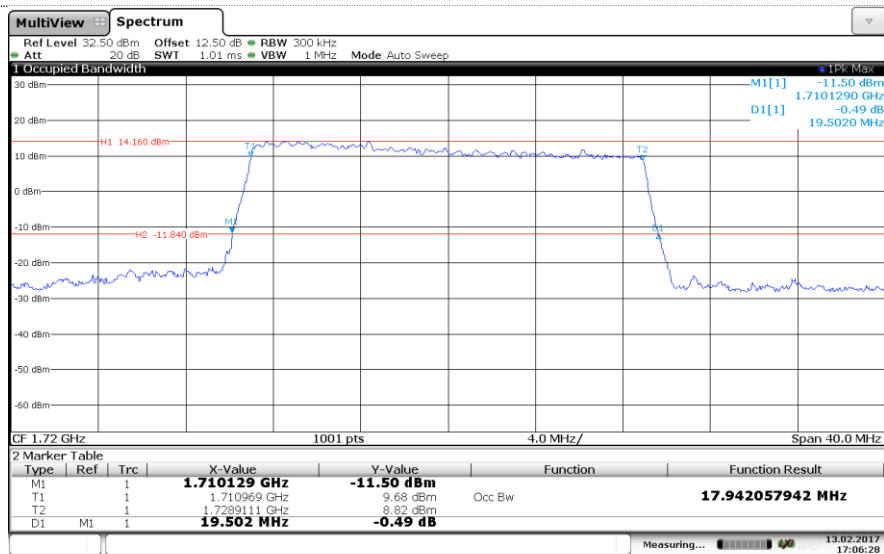
Channel Mid



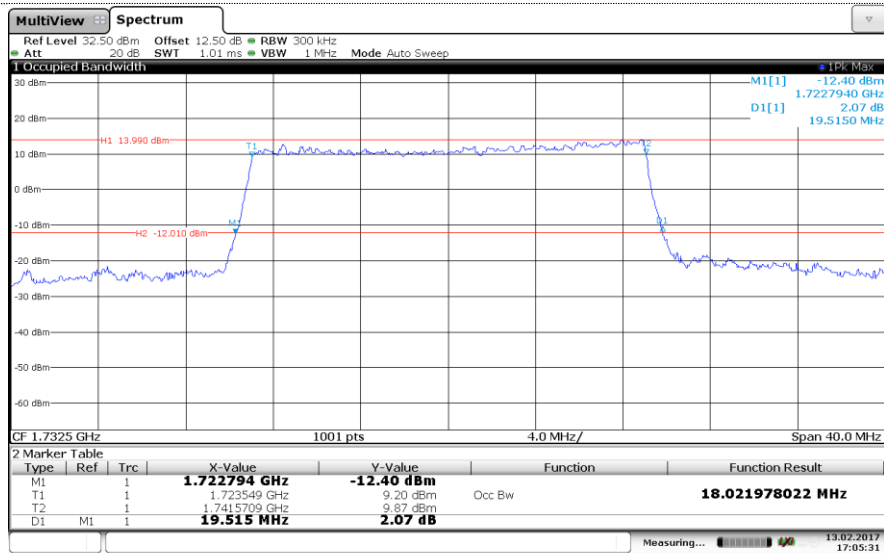
Channel High

LTE Band 4-20MHz

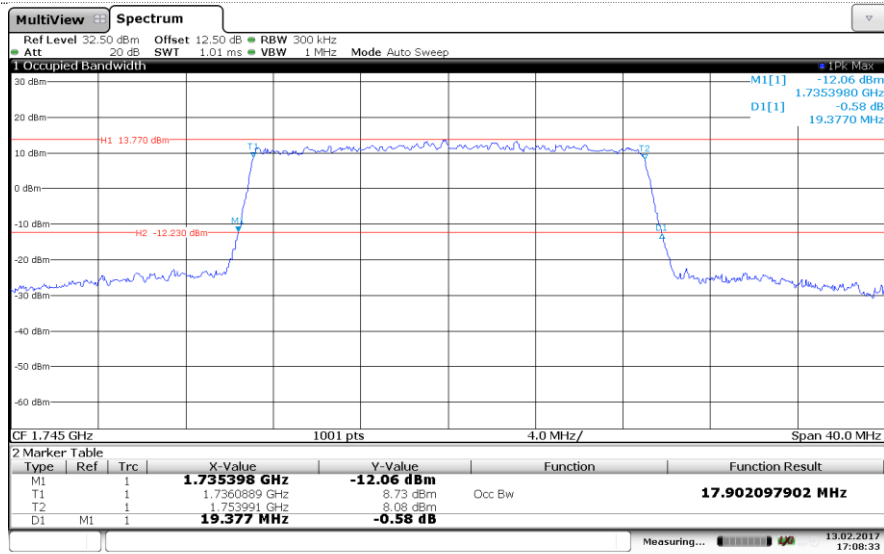
16QAM



Channel Low



Channel Mid



Channel High

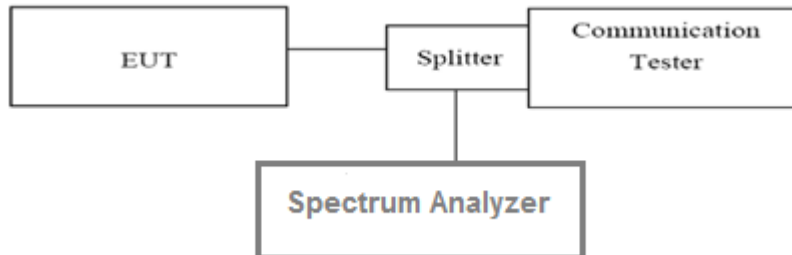
5.3. Conducted Spurious Emissions

LIMIT

Part 24.238 and Part 22.917 and Part 27.53 h(1) specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

TEST CONFIGURATION



TEST PROCEDURE

1. The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation.
2. The resolution bandwidth of the spectrum analyzer was set at 1MHz, sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic.
3. For the out of band: Set the RBW= 1MHz, VBW = 3MHz, Start=30MHz, Stop= 10th harmonic.

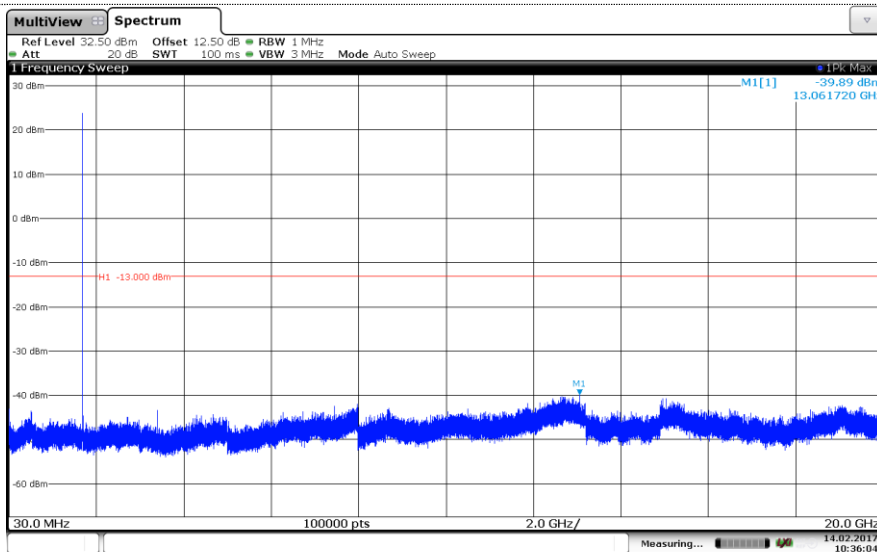
TEST MODE:

Please refer to the clause 3.3

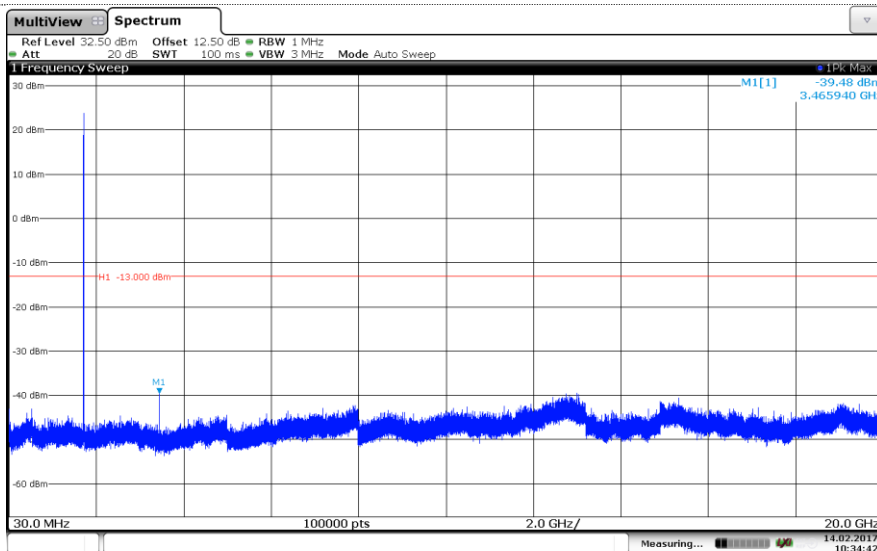
TEST RESULTS

Passed **Not Applicable**

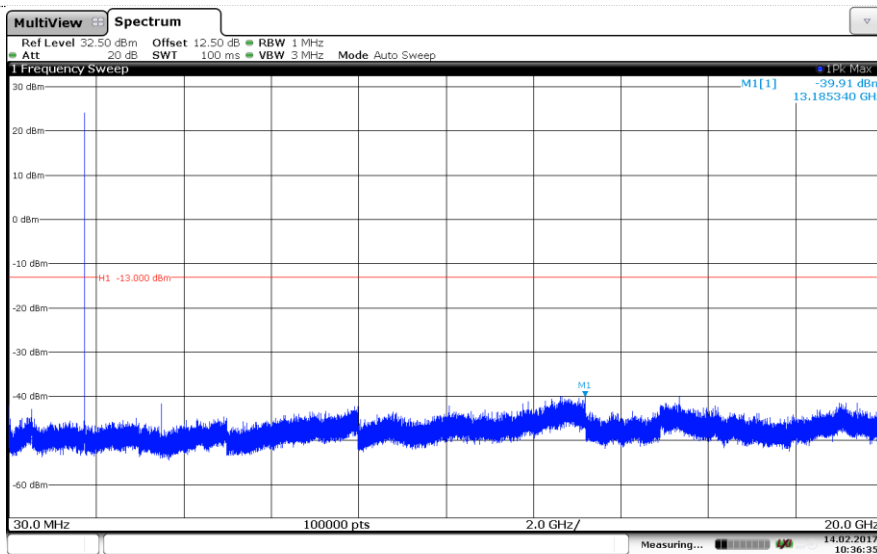
LTE Band 4-1.4MHz
QPSK



Channel Low

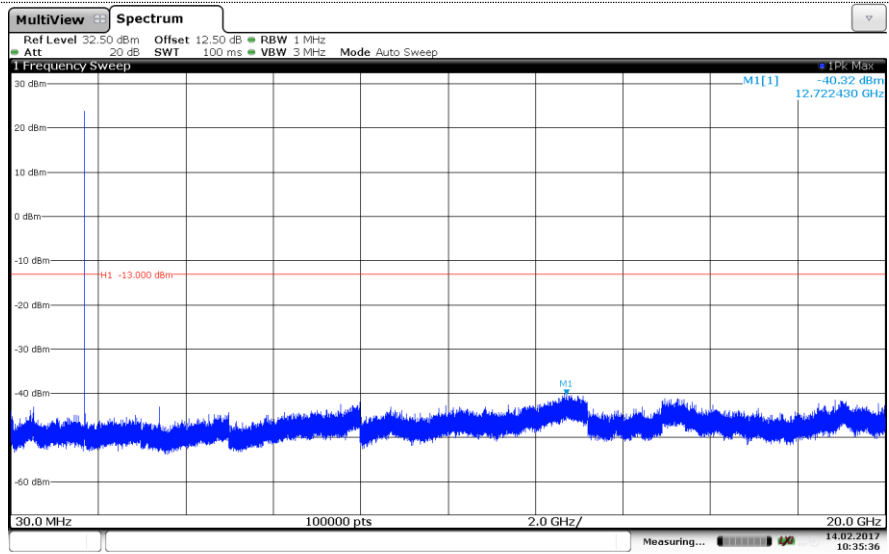


Channel Mid

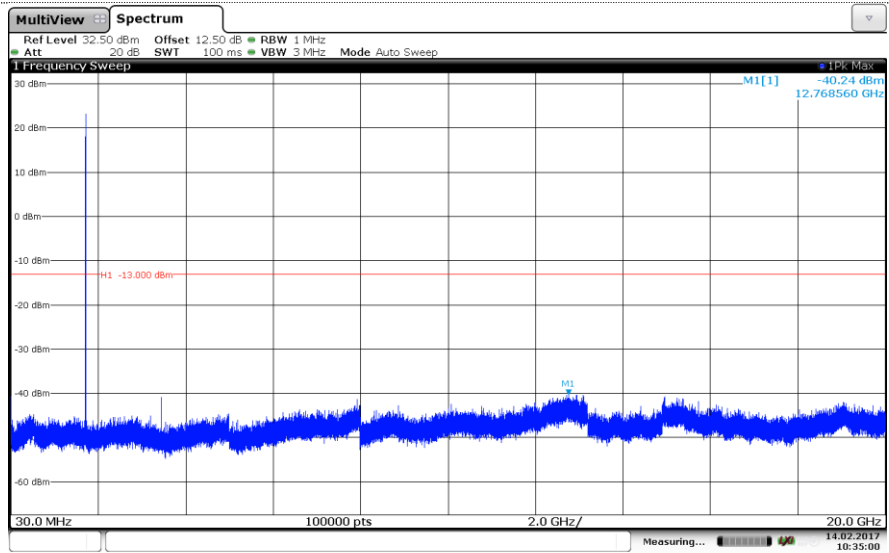


Channel High

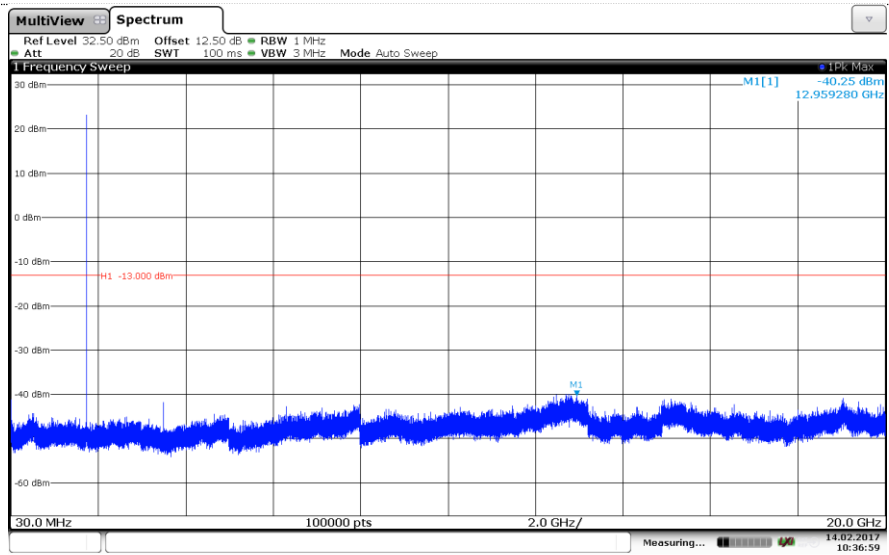
LTE Band 4-1.4MHz
16QAM



Channel Low



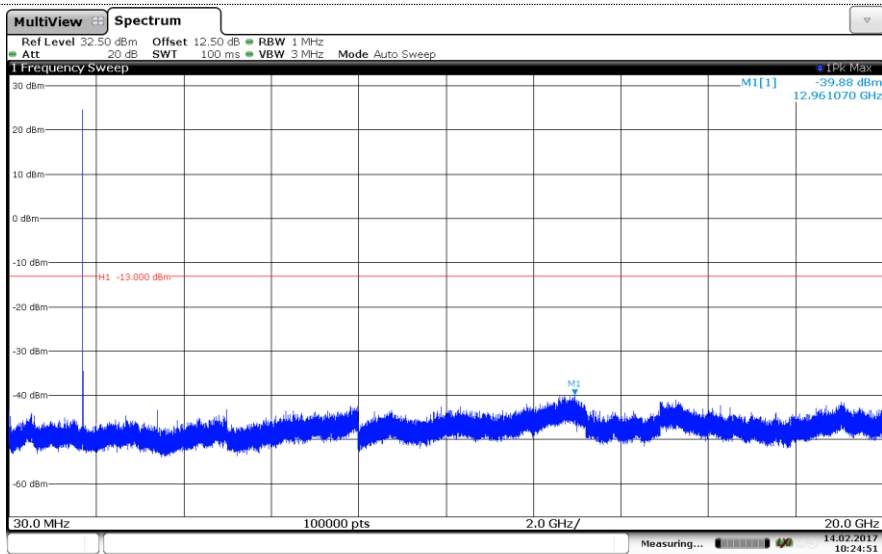
Channel Mid



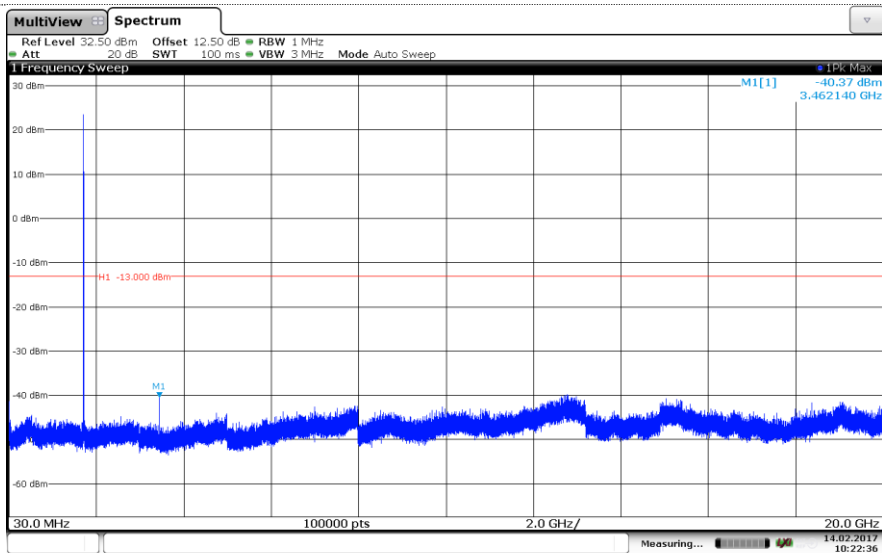
Channel High

LTE Band 4-3MHz

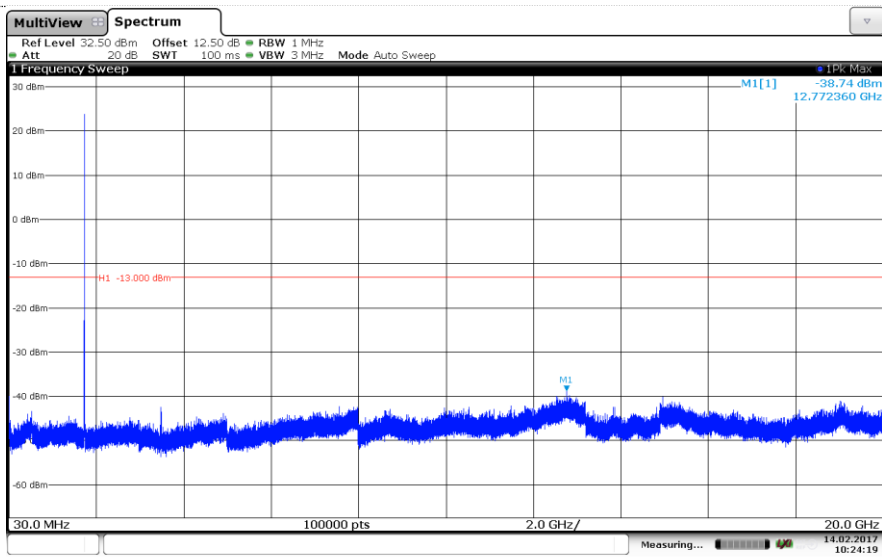
QPSK



Channel Low

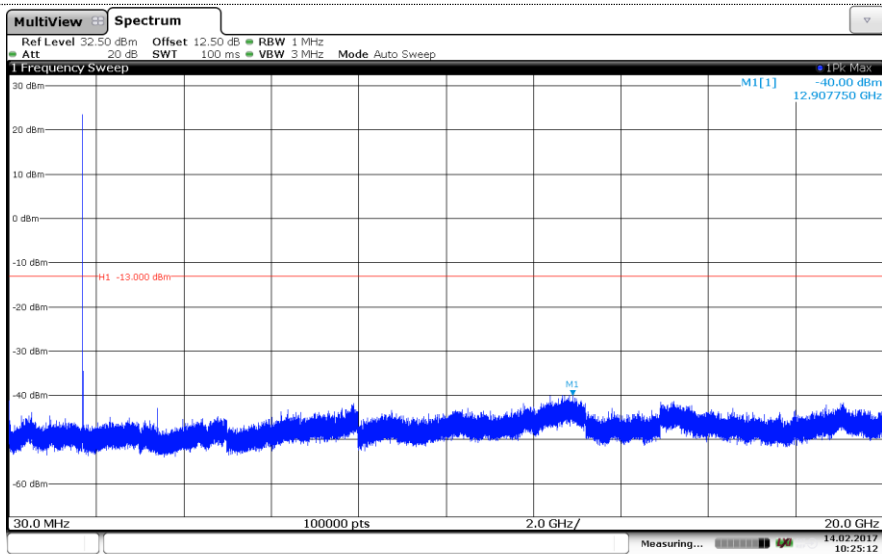


Channel Mid

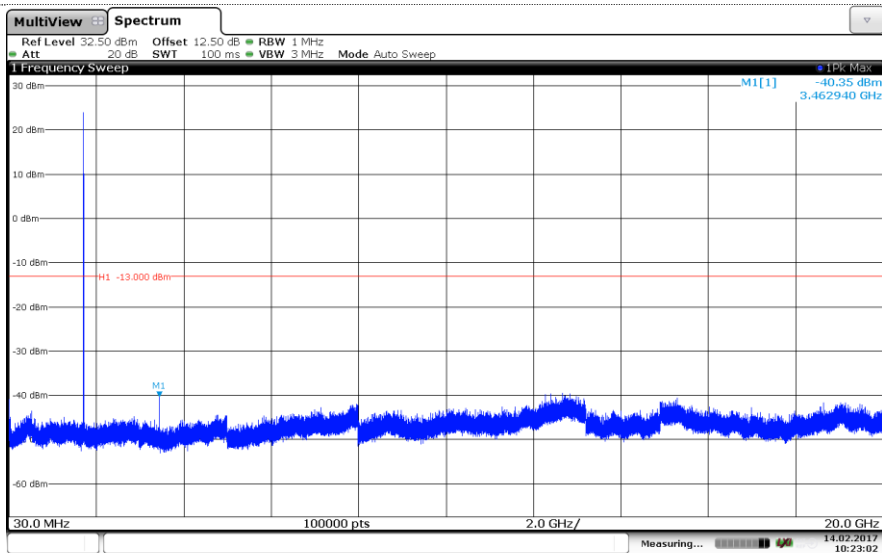


Channel High

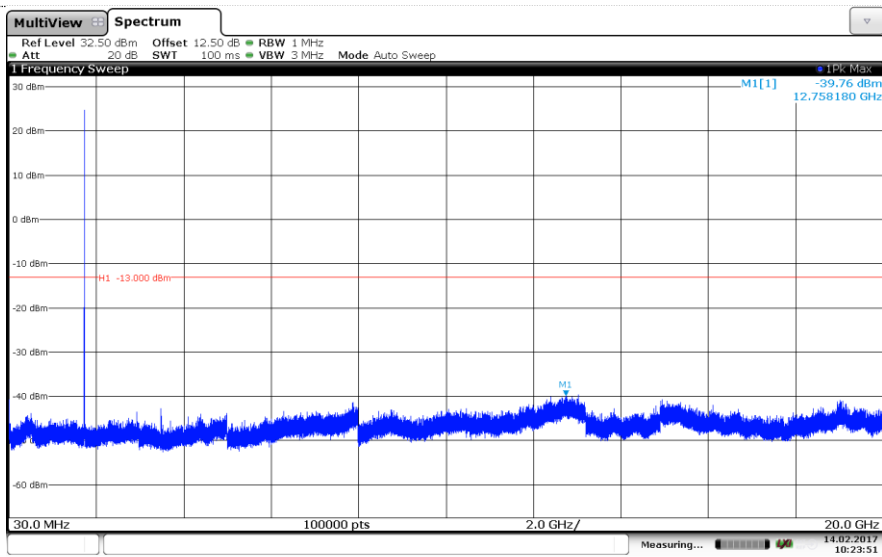
LTE Band 4-3MHz 16QAM



Channel Low



Channel Mid



Channel High